

LC²MOS 12-Bit DACPORTS

AD7245/AD7248

FEATURES

12-Bit CMOS DAC with Output Amplifier and Reference

Parallel Loading Structure: AD7245
(8+4) Loading Structure: AD7248
Single or Dual Supply Operation
Fast Digital Interface (80ns WR Pulse)
Low Power (65mW typ)
0.3", Skinny, 20- and 24-Pin DIP
20- and 28-Terminal Surface Mount Packages
NOTE: AD7245A/AD7248A IS RECOMMENDED FOR
NEW DESIGNS

GENERAL DESCRIPTION

The AD7245/AD7248 is a complete 12-bit, voltage-output, digital-to-analog converter with output amplifier and Zener voltage reference on a monolithic CMOS chip. No external trims are required to achieve full specified performance for the part.

The part features double-buffered interface logic with a 12-bit input latch and 12-bit DAC latch. The data held in the DAC latch determines the analog output of the converter. The AD7245 accepts 12-bit parallel data which is latched into the input latch on the rising edge of \overline{CS} or \overline{WR} . The AD7248 has an 8-bit-wide data bus, and data is loaded to the input latch in two write operations, an 8-bit LSB load and a 4-bit MSB load. The input data must be right justified. For both parts, an asynchronous \overline{LDAC} signal transfers data from the input latch to the DAC latch. The AD7245 also has a \overline{CLR} signal on the DAC latch which allows features such as power-on reset to be implemented. All logic inputs are level triggered and are TTL and CMOS (5V) level compatible, while the control logic is speed compatible with most microprocessors.

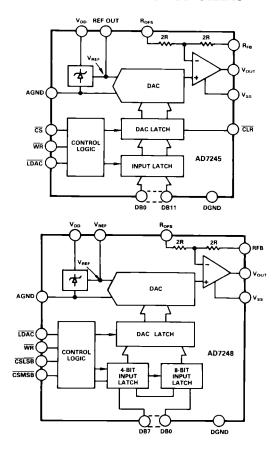
The on-chip 5V buried Zener diode provides a low-noise, temperature compensated reference for the DAC. The gain setting resistors allow a number of ranges at the output: 0 to +5V, 0 to +10V when using single supply and 0 to +5V, -5V to +5V when operated in dual supplies. The output amplifier is capable of developing +10V across a $2k\Omega$ load to GND.

The AD7245/AD7248 is fabricated in an all ion-implanted, high-speed linear, compatible CMOS (LC²MOS) process. The AD7245 is packaged in a small, 0.3"-wide, 24-pin DIP and 28-terminal surface mount packages. The AD7248 is available in a 0.3"-wide, 20-pin DIP and 20-terminal surface mount packages.

REV. A

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FUNCTIONAL BLOCK DIAGRAMS



PRODUCT HIGHLIGHTS

- 1. Complete 12-Bit DACPORTTM
 - The AD7245/AD7248 is a complete, voltage output, 12-bit DAC on one chip. This single-chip design of the DAC reference and output amplifier is inherently more reliable than multichip designs.
- 2. Microprocessor Compatibility

The parallel loading structure of the AD7245 allows connection to microprocessors with a 16-bit-wide data bus. The AD7248 is aimed at microprocessors which have an 8-bit-wide data bus structure. The high-speed logic of both parts allows direct interfacing to most modern microprocessors. Additionally, the double buffered interface enables simultaneous update of the AD7245/AD7248 in multiple DAC systems.

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SPECIFICATIONS

SINGLE SUPPLY $(V_{DD}=+15V\pm5\%^1,V_{SS}=AGND=DGND=0V;R_L=2k\Omega$ to GND; $C_L=100pF$ to GND; REF OUT unloaded unless otherwise stated. All specifications T_{min} to T_{max} unless otherwise stated.)

Parameter	J, A Version ²	S Version ²	Units	Test Conditions/Comments
STATIC PERFORMANCE				
Resolution	12	12	Bits	
Relative Accuracy	± 1		LSB max	
,		± 1	LSB max	$V_{DD} = +11.4V \text{ to } +14.25V$
		± 1.5	LSB max	$V_{DD} = +14.25 \text{V to} + 15.75 \text{V}$
Differential Nonlinearity ³	±1	± 1	LSB max	Guaranteed Monotonic
Unipolar Offset Error ³			202	Guaranteea Monotonia
at +25°C	± 3	± 3	LSB max	
T _{min} to T _{max}	±5	±5	LSB max	Typical Tempco is ± 3 ppm of FSR 4 /°C
DAC Gain Error ^{3,5}	± 2	±2	LSB max	Typical Tempeous = Sppinor For FC
Full-Scale Output Voltage Error ⁶	_ 		Loo max	
$T_A = +25^{\circ}C$	±0.2	±0.2	% of FSR max	$V_{DD} = +15V \text{ for } J, A \text{ Grades};$
		- 52	,001101111111	$V_{DD} = +12V & +15V \text{ for S Grade}$
T_{min} to T_{max}		± 0.6	% of FSR max	$V_{DD} = + 12V \& + 15V$
Δ Full Scale/ Δ V _{DD}		_ 0.0	70 01 1 51 1 III.	1 100 1121 W 1151
$T_A = +25^{\circ}C$	±0.12	± 0.12	% of FSR/V max	$\Delta V_{DD} = +5\%$
Full-Scale Temperature		_0.12	70 OI I SIC V IIIAX	1 4 bb - 1 5/0
Coefficient ⁷	± 30		ppm of FSR/°C max	
$\Delta Offset/\Delta V_{DD}$	± 1	± 2	mV max	$\Delta V_{DD} = \pm 5\%$
			III V III ax	4 DD - 23/0
REFERENCE				
Reference Output $(a + 25^{\circ}C)$	4.99/5.01	4.99/5.01	V min to V max	$V_{DD} = +15V \text{ for } J, A \text{ Grades};$
				$V_{DD} \pm + 12V \& + 15V \text{ for S Grade}$
$\Delta Reference/\Delta V_{DD}$				
$T_A = +25^{\circ}C$	6	6	mV/V max	$\Delta V_{DD} = \pm 5\%$
Reference Temperature Coefficient	± 30	± 40	ppm of FSR/°C typ	FSR = 5V
Reference Load Sensitivity				
$(\Delta Reference/\Delta I)$	± 1	±1.5	mV max	Reference Load Current Change (0-100μA)
DIGITAL INPUTS				
Input High Voltage, V _{INH}	2.4	2.4	V min	
Input Low Voltage, VINI	0.8	0.8	V max	
Input Current	0.0	0.0	Y IIIAX	
I _{IN} (Data Inputs)				$V_{IN} = 0V \text{ or } V_{DD}$
at +25°C	± 1	± l	μA max	VIN CV CL VDD
T _{min} to T _{max}	± 10	± 10	μA max	
I _{INH} (Control Inputs) ⁸	- 10		F	$V_{IN} = V_{DD}$
at + 25°C	± 1	± 1	A	VIN - VDD
T _{min} to T _{max}	± 10	± 10	μA max	
	± 10	± 10	μA max	
I _{INL} (Control Inputs) ⁸				$V_{IN} = 0V$
at + 25°C	150	150	μA max	
T _{min} to T _{max}	200	200	μA max	
Input Capacitance ⁹ (AD7245)	8	8	pF max	
Input Capacitance ⁹ (AD7248)	16	16	pF max	
ANALOG OUTPUT				
Output Range Resistors	15/30	15/30	$k\Omega$ min/ $k\Omega$ max	
Ranges	+ 5, + 10	+ 5, + 10	v	Pin Strappable. Min Load Resistance is 2kΩ to GND
de Output Impedance	0.5	0.5	Ω typ	1
Short-Circuit Current	40	40	mA typ	
DYNAMIC PERFORMANCE9				
				Settling Time to ± 1 LSB. $R_L = 5k\Omega$, $C_L = 100pF$
Output Voltage Settling Time Positive Full-Scale Change	5	8	μs max	Settling Time to ± 1258 . $R_L = 5811$, $C_L = 100$ pF DAC Register all 0s to all 1s
Negative Full-Scale Change	10	10	· •	DAC Register all 0s to all 1s DAC Register all 1s to all 0s
Output Voltage Slew Rate	2	1.5	μs typ V/μs min	DUC VERISIES WILLS STATE OF
Digital Feedthrough ^{3,10}	10	1.5	nV secs typ	
Digital reedthrough		30		Major Carry Transition
	30	30	nV secs typ	Major Carry Transition
POWER SUPPLIES				
$V_{ m DD}$ Range	14.25/15.75	11.4/15.75	V min/V max	For Specified Performance
$I_{ m DD}$				Output Unloaded
at + 25°C	9	9	mA max	Typically 4.5mA
T_{min} to T_{max}	12	12	mA max	
				<u> </u>

NOTES

 $^{^{1}}$ For the S Version only: $V_{\rm DD} = +12 V \pm 5\%$ to $+15 V \pm 5\%$ 2 Temperature ranges are as follows:

J Version, 0 to + 70°C A Version, - 25°C to + 85°C S Version, - 55°C to + 125°C.

FSR means Full-Scale Range and is 5V with R_{OFS} connected to R_{FB}, V_{OUT} and 10V with R_{OFS} connected to GND and R_{FB} connected to V_{OUT}.

⁵This error is calculated with respect to the reference voltage and is measured after the offset error has been allowed for.

⁶This error is calculated w.r.t. an ideal 4.9988V (on the 5V range) or 9.9976V (on the 10V range).

It includes the effects of internal voltage reference, gain and offset errors.
Full-scale T.C. = $\Delta FS/\Delta T$, where ΔFS is the full-scale change from $T_A = +25^{\circ}C$ to T_{min} or T_{max} .
Control inputs are \overline{CS} , \overline{WR} , \overline{LDAC} and \overline{CLR} for AD7245 and \overline{CSMSB} , \overline{CSLSB} , \overline{WR} and \overline{LDAC} for AD7248.

⁹Sample tested at + 25°C to ensure compliance.

¹⁰The metal lid on the AD7245 (only) ceramic (D-24A) package is connected to Pin 12 (DGND).

Specifications subject to change without notice.

 $\begin{array}{l} \textbf{SPECIFICATIONS} \\ \textbf{DUAL SUPPLY} & (\textbf{V}_{DO} = +15 \textbf{V} \pm 5 \%^1. \ \textbf{V}_{SS} = -15 \textbf{V} \pm 5 \%^1. \ \textbf{AGND} = \textbf{DGND} = \textbf{OV}; \ \textbf{R}_L = 2 \textbf{k} \Omega \ \text{to GND}; \ \textbf{C}_L = 100 \textbf{pF to GND}; \ \textbf{REF OUT unloaded unless otherwise stated.} \\ \textbf{All specifications T}_{min} \ \text{to T}_{max} \ \text{unless otherwise stated.} \\ \end{array}$

Parameter	J, A Version ²	S Version ²	Units	Test Conditions/Comments
STATIC PERFORMANCE				
Resolution	12	12	Bits	
Relative Accuracy ³	±1		LSB max	
Relative Accuracy			LSB max	$V_{\rm DD}/V_{\rm SS} = \pm 11.4 \text{V to } \pm 14.25 \text{V}$
			LSB max	$V_{DD}/V_{SS} = \pm 14.25 \text{V to} \pm 15.75 \text{V}$
Porce 11 137 - 101 - 1113			LSB max	Guaranteed Monotonic
Differential Nonlinearity ³	±1	-1	Lobinax	R _{OFS} Connected to REF OUT
Bipolar Zero Offset Error ³			LSB max	MOFS COMMONDE TO THE
at +25°C		_		Typical Tempco is ± 3ppm of FSR ⁴ /°C
T _{min} to T _{max}	-		LSB max	Typical Tempeous = Sppinor Fore
DAC Gain Error ^{3,5}	± 2	± 2	LSB max	
Full-Scale Output Voltage Error ⁶				TI OI ISVE-I A Credos
$T_A = +25^{\circ}C$	±0.2	± 0.2	% of FSR max	$V_{DD}/V_{SS} = \pm 15V \text{ for } J, A \text{ Grades};$
	l			$V_{DD}/V_{SS} = \pm 12V \& \pm 15V \text{ for S Grade}$
T_{min} to T_{max}		± 0.6	% of FSR max	$V_{DD}/V_{SS} = \pm 12V \& \pm 15V$
Δ Full Scale/ Δ V _{DD}				
$T_A = +25^{\circ}C$	± 0.12	± 0.12	% of FSR/V max	$\Delta V_{DD} = \pm 5\%$
	_0.12			
ΔFull Scale/ΔV _{SS}		± 0.01	% of FSR/V max	$\Delta V_{SS} = \pm 5\%$
$T_A = +25^{\circ}C$	±0.01	±0.01	70 OI I SIO V IIIAX	2.32
Full-Scale Temperature		1	of ECD /0C	1
Coefficient ⁷	± 30		ppm of FSR/°C max	A37 - +50/
$\Delta Offset/\Delta V_{DD}$	±1	± 2	mV max	$\Delta V_{DD} = \pm 5\%$
$\Delta Offset/\Delta V_{SS}$	±1	± 1	mV max	$\Delta V_{SS} = \pm 5\%$
REFERENCE		4.00/5.03	V min to V may	$V_{DD}/V_{SS} = \pm 15V$ for J, A Grades;
Reference Output (a + 25°C	4.99/5.01	4.99/5.01	V min to V max	$V_{DD}/V_{SS} = \pm 12V \& \pm 15V \text{ for S Grade}$
]			VDD/VSS = ± 12 V & ± 15 V for 5 Grade
$\Delta Reference/\Delta V_{DD}$				50.
$T_A = +25^{\circ}C$	6	6	mV/V max	$\Delta V_{DD} = \pm 5\%$
Reference Temperature Coefficient	± 30	± 40	ppm of FSR/°C typ	FSR = 5V
Reference Load Sensitivity				Reference Load Current Change
	± 1	± 1.5	mV max	(0-100μA) (Not Including R _{OFS} Current)
(ΔReference/ΔI)	<u> </u>			
DIGITAL INPUTS				
Input High Voltage, VINH	2.4	2.4	V min	
Input Low Voltage, VINI	0.8	0.8	Vmax	•
•	***			
Input Current	ì			$V_{IN} = 0V \text{ or } V_{DD}$
I _{IN} (Data Inputs)	1.,	± 1	μA max	
at +25°C	± 1	1	μA max	
T_{min} to T_{max}	± 10	± 10	μπιιιαχ	37 37
I _{INH} (Control Inputs) ⁸				$V_{IN} = V_{DD}$
at + 25°C	±1	± 1	μA max	
T _{min} to T _{max}	± 10	± 10	μA max	
				$V_{IN} = 0V$
I _{INL} (Control Inputs) ⁸	1.50	150	μA max	- II.
at +25°C	150	150	, ·	
T_{min} to T_{max}	200	200	μA max	
Input Capacitance ⁹ (AD7245)	8	8	pF max	
Input Capacitance ⁹ (AD7248)	16	16	pF max	
ANALOGOUTPUT	15/20	15/20	kΩ min/kΩ max	
Output Range Resistors	15/30	15/30	1	Pin Strappable. Min Load Resistance is 2kΩ to GNE
Ranges	$\pm 5, + 5$	$\pm 5, + 5$	V	i ni dii appaole. Mili Boad resistante is 174 to 51
dc Output Impedance	0.5	0.5	Ωtyp	
Short-Circuit Current	40	40	mA typ	
DYNAMIC PERFORMANCE9		1		Settling Time to $\pm 1LSB$. $R_L = 5k\Omega$, $C_L = 100pF$
Output Voltage Settling Time	1.	110	μs max	DAC Register all 0s to all 1s
Positive Full-Scale Change	5	10		DAC Register all 1s to all 0s
Negative Full-Scale Change	10	10	μs max	Direction and to to am or
Output Voltage Slew Rate	2	1.5	V/μs min	
Digital Feedthrough ^{3,10}	10	10	nV secs typ	W. C. Torresision
Digital-to-Analog Glitch Impulse	30	30	nV secs typ	Major Carry Transition
	+		 	
POWER SUPPLIES		11 405 75	V min/V man	For Specified Performance
$ m V_{DD}$ Range	14.25/15.75	11.4/15.75	V min/V max	For Specified Performance
V _{SS} Range	- 14.25/ - 15.7	5 – 11.4/ – 15.75	V min/V max	
I _{DD}				Output Unloaded
at + 25°C	9	9	mA max	Typically 5mA
	12	12	mA max	
T_{min} to T_{max}	1 "	1-		Output Unloaded
Iss	1,]2	mA max	Typically 2mA
25%	3	3	IIII III III III III III III III III I	- , p ,
at $+25^{\circ}$ C T _{min} to T _{max}	5	15	mA max	

NOTES

For the S Version only: $V_{DD} = +12V \pm 5\%$ to $+15V \pm 5\%$; $V_{SS} = -12V \pm 5\%$ to $-15V \pm 5\%$.

²Temperature ranges are as follows:

J Version, 0 to +70°C

A Version, -25°C to +85°C

S Version, -55°C to +125°C.

³See Terminology.

 4 FSR means Full-Scale Range and is 5V with R $_{
m OFS}$ connected to R $_{
m FB}$, V $_{
m OUT}$ and 10V with R $_{
m OFS}$ connected to GND and R $_{
m FB}$ connected to V $_{
m OUT}$.

⁵This error is calculated with respect to the reference voltage and is measured after the offset error has been allowed for.

 6 This error is calculated w.r.t. an ideal 4.9988V (on the 5V range) or 9.9976V (on the 10V range).

It includes the effects of internal voltage reference, gain and offset errors.

⁷Full-scale T.C. = $\Delta F S / \Delta T$, where $\Delta F S$ is the full-scale change from $T_A = +25^{\circ}C$ to T_{min} or T_{max}

⁸Control inputs are CS, WR, LDAC and CLR for AD7245 and CSMSB, CSLSB, WR and LDAC for AD7248.

⁹Sample tested at + 25°C to ensure compliance.

¹⁰The metal lid on the AD7245 (only) ceramic (D-24A) package is connected to Pin 12 (DGND).

Specifications subject to change without notice.

SWITCHING CHARACTERISTICS $(V_{DD} = +15V \pm 5\%^2; V_{SS} = 0V \text{ or } -15V \pm 5\%^2; \text{ See Figures 5 and 7})$

Parameter	J Grade	A Grade	S Grade	Units	Conditions
$(a + 25^{\circ}C)$	80	80	105	ns min	Chip Select Pulse Width
T_{min} to T_{max}	100	100	135	ns min	
t_2	1				
$(a + 25^{\circ}C)$	80	80	105	ns min	Write Pulse Width
T_{min} to T_{max}	100	100	135	ns min	
t ₃					
$(a + 25^{\circ}C)$	0	0	0	ns min	Chip Select to Write Setup Time
T_{min} to T_{max}	0	0	0	ns min	
t ₄					
(<i>a</i> + 25°C	0	0	0	ns min	Chip Select to Write Hold Time
T_{min} to T_{max}	0	0	0	ns min	
t ₅ (AD7245 Only)					
$(a + 25^{\circ}C)$	100	100	155	ns min	Data Valid to Write Setup Time
T _{min} to T _{max}	110	130	250	ns min	
t ₅ (AD7248 Only)					
(a + 25°C	110	110	180	ns min	Data Valid to Write Setup Time
T_{min} to T_{max}	130	130	270	ns min	1
t ₆					
$(a + 25^{\circ}C)$	10	10	10	ns min	Data Valid to Write Hold Time
T_{min} to T_{max}	10	10	10	ns min	
t ₇					
$(a + 25^{\circ}C)$	80	80	90	ns min	Load DAC Pulse Width
T _{min} to T _{max}	100	100	120	ns min	
t ₈ (AD7245 Only)					
(a + 25°C	80	80	140	ns min	Clear Pulse Width
T _{min} to T _{max}	100	100	200	ns min	

NOTE

Specifications subject to change without notice.

ABSOLUTE MAXIMUM RATINGS*

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V_{DD} to AGND0.3V, +17V
V_{DD} to DGND0.3V, +17V
V_{DD} to V_{SS}
AGND to DGND0.3V, V_{DD}
Digital Input Voltage to DGND $\dots -0.3V, V_{DD} +0.3V$
V_{OUT} to AGND ¹ V_{SS}, V_{DD}
V_{OUT} to V_{SS}^{-1}
V_{OUT} to V_{DD}^{-1}
REF OUT 1 to AGND 0V, V_{DD}
Power Dissipation (Any Package) to +75°C 450mW
Derates above 75°C by 6mW/°C
Operating Temperature
Commercial 0 to +70°C

Industrial	-25°C to $+85^{\circ}\text{C}$
Extended	-55°C to $+125$ °C
Storage Temperature	-65°C to +150°C
Lead Temperature (Soldering, 10secs)	+ 300°C
NOTE	

¹The output may be shorted to voltages in this range provided the power dissipation of the package is not exceeded.

*Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

CAUTION -

ESD (electrostatic-discharge) sensitive device. The digital control inputs are diode protected; however, permanent damage may occur on unconnected devices subject to high energy electrostatic fields. Unused devices must be stored in conductive foam or shunts. The protective foam should be discharged to the destination socket before devices are removed.



¹Sample tested at +25°C to ensure compliance.

²For the S Version only: $V_{DD} = +12V \pm 5\%$ to $+15V \pm 5\%$; $V_{SS} = 0V$ or $-12V \pm 5\%$ to $-15V \pm 5\%$.

TERMINOLOGY

RELATIVE ACCURACY

Relative Accuracy, or end-point nonlinearity, is a measure of the actual deviation from a straight line passing through the end-points of the DAC transfer function. It is measured after allowing for zero and full scale and is normally expressed in LSBs or as a percentage of full-scale reading.

DIFFERENTIAL NONLINEARITY

Differential Nonlinearity is the difference between the measured change and the ideal 1LSB change between any two adjacent codes. A specified differential nonlinearity of \pm 1LSB max over the operating temperature range ensures monotonicity.

DIGITAL FEEDTHROUGH

Digital Feedthrough is the glitch impulse injected from the digital inputs to the analog output when the inputs change state. It is measured with \overline{LDAC} high and is specified in nV secs.

DAC GAIN ERROR

DAC Gain Error is a measure of the output error between an ideal DAC and the actual device output with all 1s loaded after offset error has been allowed for. It is therefore defined as:

Measured Value - Offset - Ideal Value

where the ideal value is calculated relative to the actual reference value.

UNIPOLAR OFFSET ERROR

Unipolar Offset Error is a combination of the offset errors of the voltage-mode DAC and the output amplifier and is measured when the part is configured for unipolar outputs. It is present for all codes and is measured with all 0s in the DAC register.

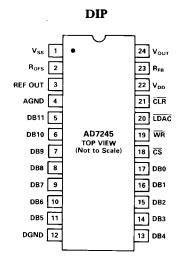
BIPOLAR ZERO OFFSET ERROR

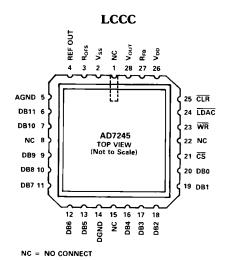
Bipolar Zero Offset Error is measured when the part is configured for bipolar output and is a combination of errors from the DAC and output amplifier. It is present for all codes and is measured with a code of 2048 (decimal) in the DAC register.

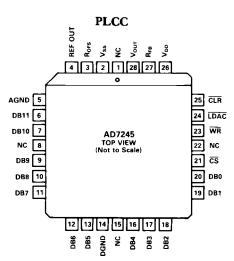
AD7245 PIN FUNCTION DESCRIPTION (DIP PIN NUMBERS)

Pin	Mnemonic	Description	Pin	Mnemonic	Description
1	V_{SS}	Negative Supply Voltage (0V for single	18	$\overline{\text{CS}}$	Chip Select Input (Active LOW). The device
2	R_{OFS}	supply operation). Bipolar Offset Resistor. This provides access to the on-chip application resistors and allows different output voltage ranges.	19	WR	is selected when this input is active. Write Input (Active LOW). This is used in conjunction with \overline{CS} to write data into the
3	REF OUT	Reference Output. The on-chip reference is provided at this pin and is used when configuring the part for bipolar outputs.	20	LDAC	input latch of the AD7245. Load DAC Input (Active LOW). This is an asynchronous input which when active transfers data from the input latch to
4	AGND	Analog Ground.			the DAC latch.
5 6–11 12	DB11 DB10-DB5 DGND	Data Bit 11. Most Significant Bit (MSB). Data Bit 10 to Data Bit 5. Digital Ground.	21	CLR	Clear Input (Active LOW). When this input is active the contents of the DAC latch are reset to all 0s.
	DB4-DB1	Data Bit 4 to Data Bit 1.	22	V_{DD}	Positive Supply Voltage.
17	DB0	Data Bit 0. Least Significant Bit (LSB).	23	R_{FB}	Feedback Resistor. This allows access to the amplifier's feedback loop.
			24	V _{OUT}	Output Voltage. Three different output voltage ranges can be chosen: $0 \text{ to } + 5\text{V}$, $0 \text{ to } + 10\text{V}$ or -5V to $+5\text{V}$.

AD7245 PIN CONFIGURATIONS



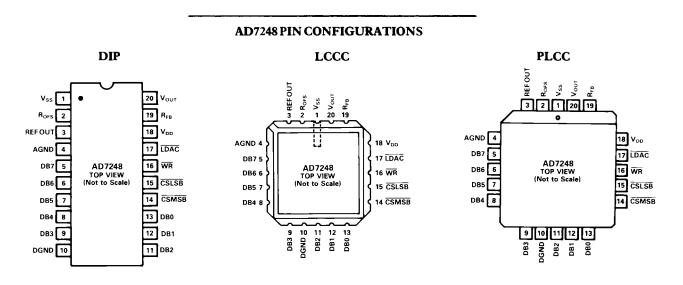




NC = NO CONNECT

AD7248 PIN FUNCTION DESCRIPTION (ANY PACKAGE)

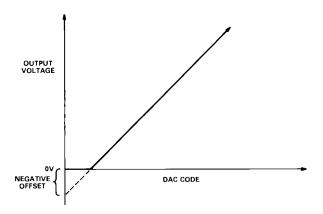
Pin	Mnemonic	Description	Pin	Mnemonic	Description
1	V_{SS}	Negative Supply Voltage (0V for single supply operation).	14	CSMSB	Chip Select Input for MS Nibble. (Active LOW). This selects the upper 4 bits of the
2	R_{OFS}	Bipolar Offset Resistor. This provides access to the on-chip application resistors and allows different output voltage ranges.	15	CSLSB	input latch. Input data is right-justified. Chip Select Input for LS byte. (Active LOW). This selects the lower 8 bits of the
3	REFOUT	Reference Output. The on-chip reference is provided at this pin and is used when configuring the part for bipolar outputs.	16	WR	input latch. Write Input. This is used in conjunction with CSMSB and CSLSB to load data into
4	AGND	Analog Ground.			the input latch of the AD7248.
5	DB7	Data Bit 7.	17	$\overline{\text{LDAC}}$	Load DAC Input (Active LOW). This is an
6	DB6	Data Bit 6.			asynchronous input which when active trans-
7	DB5	Data Bit 5.			fers data from the input latch to the DAC
8	DB4	Data Bit 4.			latch.
9	DB3	Data Bit 3/Data Bit 11 (MSB).	18	$V_{ m DD}$	Positive Supply Voltage.
10	DGND	Digital Ground.	19	R_{FB}	Feedback Resistor. This allows access to
11	DB2	Data Bit 2/Data Bit 10.			the amplifier's feedback loop.
12	DB1	Data Bit 1/Data Bit 9.	20	V_{OUT}	Output Voltage. Three different output
13	DB0	Data Bit 0 (LSB)/Data Bit 8.			voltage ranges can be chosen: $0 \text{ to } +5\text{V}$, $0 \text{ to } +10\text{V}$ or -5V to $+5\text{V}$.



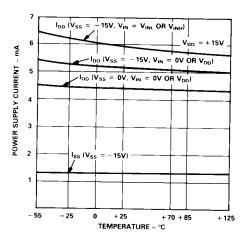
SINGLE SUPPLY LINEARITY AND GAIN ERROR

The output amplifier of the AD7245/AD7248 can have a true negative offset even when the part is operated from a single positive power supply. However, because the lower supply rail to the part is 0V, the output voltage cannot actually go negative. Instead the output voltage sits on the lower rail and this results in the transfer function shown across. This is an offset effect and the transfer function would have followed the dotted line if the output voltage could have gone negative. Normally, linearity is measured after offset and full scale have been adjusted or allowed for. On the AD7245/AD7248 the negative offset is allowed for by calculating the linearity from the code which the amplifier comes off the lower rail. This code is given by the negative offset specification. For example, the single supply linearity specification applies between Code 3 and Code 4095 for the 25°C specification and between Code 5 and Code 4095 over the T_{min} to T_{max} temperature range. Since gain error is also

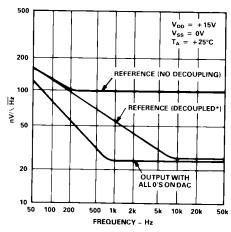
measured after offset has been allowed for, it is calculated between the same codes as the linearity error. Bipolar linearity and gain error are measured between Code 0 and Code 4095.



Typical Performance—AD7245/AD7248

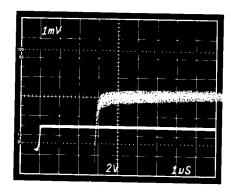


Power Supply Current vs. Temperature

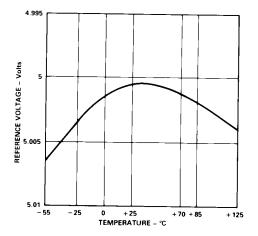


*REFERENCE DECOUPLING COMPONENTS AS PER FIGURE 8

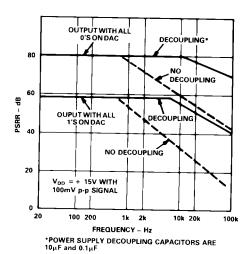
Noise Spectral Density vs. Frequency



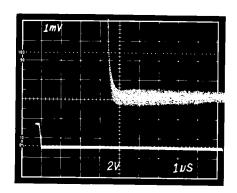
Positive-Going Settling Time $(V_{DD} = +15V, V_{SS} = -15V)$



Reference Voltage vs. Temperature



Power Supply Rejection Ratio vs. Frequency



Negative-Going Settling Time $(V_{DD} = +15V, V_{SS} = -15V)$

CIRCUIT INFORMATION

D/A SECTION

The AD7245/AD7248 contains a 12-bit voltage-mode digital-toanalog converter. The output voltage from the converter has the same positive polarity as the reference voltage allowing single supply operation. The reference voltage for the DAC is provided by an on-chip buried-Zener diode.

The DAC consists of a highly stable, thin-film, R-2R ladder and twelve high-speed NMOS single-pole, double-throw switches. The simplified circuit diagram for this DAC is shown in Figure 1.

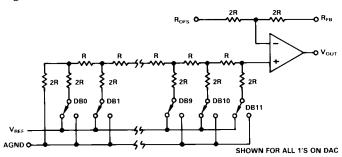


Figure 1. D/A Simplified Circuit Diagram

The input impedance of the DAC is code dependent and can vary from $8k\Omega$ to infinity. The input capacitance also varies with code, typically from 50pF to 200pF.

OP AMP SECTION

The output of the voltage-mode D/A converter is buffered by a noninverting CMOS amplifier. The user has access to two gain setting resistors which can be connected to allow different output voltage ranges (discussed later). The buffer amplifier is capable of developing up to 10V across a $2k\Omega$ load to GND.

The output amplifier can be operated from a single positive power supply by tying $V_{SS} = AGND = 0V$. The amplifier can also be operated from dual supplies to allow a bipolar output range of -5V to +5V. The amplifier should not be configured for the 0 to +10V output range when V_{SS} is more negative than -5V. For dual supply operation on this range a V_{SS} of -5V should be applied to the part. The advantage of having dual supplies for the unipolar output ranges are faster settling time to voltages near 0V, full-sink capability of 2.5mA maintained over the entire output range and elimination of the effects of negative offset on the transfer characteristic (outlined previously). Figure 2 shows the sink capability of the amplifier for single supply operation.

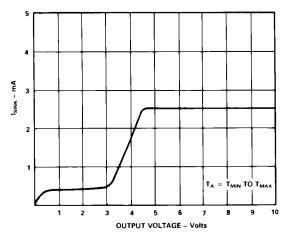


Figure 2. Typical Single Supply Sink Current vs. Output Voltage

The small-signal (200mV p-p) bandwidth of the output buffer amplifier is typically 1MHz. The output noise from the amplifier is low with a figure of $25 \text{nV}/\sqrt{\text{Hz}}$ at a frequency of 1kHz. The broadband noise from the amplifier has a typical peak-to-peak figure of 150µV for a 1MHz output bandwidth. There is no significant difference in the output noise between single and dual supply operation.

VOLTAGE REFERENCE

The AD7245/AD7248 contains an internal low-noise buried-Zener diode reference which is trimmed for absolute accuracy and temperature coefficient. The reference is internally connected to the DAC. Since the DAC has a variable input impedance at its reference input the Zener diode reference is buffered. This buffered reference is available to the user to drive the circuitry required for bipolar output ranges. It can be used as a reference for other parts in the system provided it is externally buffered. The reference will give long-term stability comparable with the best discrete Zener reference diodes. The performance of the AD7245/AD7248 is specified with internal reference, and all the testing and trimming is done with this reference. The reference should be decoupled at the REF OUT pin and recommended decoupling components are 10µF and 0.1µF capacitors in series with a 100 resistor. A simplified schematic of the reference circuitry is shown in

Figure 3.

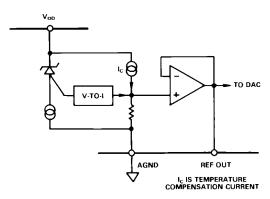


Figure 3. Internal Reference

DIGITAL SECTION

The AD7245/AD7248 digital inputs are compatible with either TTL or 5V CMOS levels. All data inputs are static-protected MOS gates with typical input currents of less than InA. The control inputs sink higher currents (150µA max) as a result of the fast digital interfacing. Internal input protection of all logic inputs is achieved by on-chip distributed diodes.

The AD7245/AD7248 features a very low digital feedthrough figure of 10nV secs in a 5V output range. This is due to the voltage-mode configuration of the DAC. Most of the impulse is actually as a result of feedthrough across the package. Normally, ceramic packages show more feedthrough than the other packages because of the metal lid. However, on the AD7245, the lid of the ceramic package is connected to DGND (Pin 12), and this reduces the feedthrough. The AD7248 metal lid is not connected to DGND on the package, but this can be done externally to reduce the feedthrough.

INTERFACE LOGIC INFORMATION - AD7245

Table I shows the truth table for AD7245 operation. The part contains two 12-bit latches, an input latch and a DAC latch. $\overline{\text{CS}}$ and WR control the loading of the input latch while LDAC controls the transfer of information from the input latch to the DAC latch. All control signals are level-triggered; and therefore either or both latches may be made transparent, the input latch by keeping \overline{CS} and \overline{WR} "LOW", the DAC latch by keeping LDAC "LOW". Input data is latched on the rising edge of

The data held in the DAC latch determines the analog output of the converter. Data is latched into the DAC latch on the rising edge of LDAC. This LDAC signal is an asynchronous signal and is independent of \overline{WR} . This is useful in many applications. However, in systems where the asynchronous \overline{LDAC} can occur during a write cycle (or vice versa) care must be taken to ensure that incorrect data is not latched through to the output. For example, if LDAC goes LOW while WR is "LOW", then the $\overline{\text{LDAC}}$ signal must stay LOW for t_7 or longer after $\overline{\text{WR}}$ goes high to ensure correct data is latched through to the output.

CLR	LDAC	WR	<u></u> CS	Function
H	L	L	L	Both Latches are Transparent
Н	Н	Н	X	Both Latches are Latched
Н	H	X	Н	Both Latches are Latched
Н	Н	L	L	Input Latches Transparent
Н	Н	₹	L	Input Latches Latched
Н	L	Н	Н	DAC Latches Transparent
Н	.	Н	Н	DAC Latches Latched
L	X	X	X	DAC Latches Loaded with all 0s
∮	H	Н	Н	DAC Latches Latched with All
			[0s and Output Remains at
				0V or -5V
.	L	L	L	Both Latches are Transparent
				and Output Follows Input
				Data

H = High State L = Low State X = Don't Care

Table I. AD7245 Truth Table

The contents of the DAC latch are reset to all 0s by a low level on the CLR line. With both latches transparent, the CLR line functions like a zero override with the output brought to 0V in the unipolar mode and -5V in the bipolar mode for the duration of the CLR pulse. If both latches are latched, a "LOW" pulse on the CLR input latches all 0s into the DAC latch and the output remains at 0V (or -5V) after the \overline{CLR} line has returned "HIGH". The CLR line can be used to ensure powerup to 0V on the AD7245 output in unipolar operation and is also useful, when used as a zero override, in system calibration cycles.

Figure 4 shows the input control logic for the AD7245 and the write cycle timing for the part is shown in Figure 5.

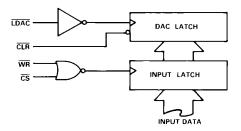
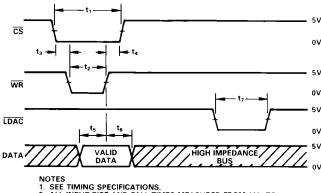


Figure 4. AD7245 Input Control Logic



- ALL INPUT RISE AND FALL TIMES MEASURED FROM 10% TO 90% OF +5V, $t_1 = 5$ ns.
 TIMING MEASUREMENT REFERENCE LEVEL IS
 - VINH + VINL
- IF TOAC IS ACTIVATED WHILE WR IS LOW THEN TOAC MUST STAY LOW FOR t, OR LONGER AFTER WR GOES HIGH.

Figure 5. AD7245 Write-Cycle Timing Diagram

INTERFACE LOGIC INFORMATION - AD7248

The input loading structure on the AD7248 is configured for interfacing to microprocessors with an 8-bit-wide data bus. The part contains two 12-bit latches - an input latch and a DAC latch. Only the data held in the DAC latch determines the analog output from the converter. The truth table for AD7248 operation is shown in Table II, while the input control logic diagram is shown in Figure 6.

CSMSB, CSLSB and WR control the loading of data from the external data bus to the input latch. The eight data inputs on the AD7248 accept right-justified data. This data is loaded to the input latch in two separate write operations. CSLSB and WR control the loading of the lower 8-bits into the 12-bit-wide latch. The loading of the upper 4-bit nibble is controlled by CSMSB and WR. All control inputs are level triggered, and input data for either the lower byte or upper 4-bit nibble is latched into the input latches on the rising edge of \overline{WR} (or either CSMSB or CSLSB). The order in which the data is loaded to the input latch (i.e., lower byte or upper 4-bit nibble first) is not important.

The LDAC input controls the transfer of 12-bit data from the input latch to the DAC latch. This LDAC signal is also level triggered, and data is latched into the DAC latch on the rising edge of \overline{LDAC} . The \overline{LDAC} input is asynchronous and independent of WR. This is useful in many applications especially in the simultaneous updating of multiple AD7248 outputs. However, in systems where the asynchronous LDAC can occur during a write cycle (or vice versa) care must be taken to ensure that

incorrect data is not latched through to the output. In other words, if \overline{LDAC} goes low while \overline{WR} and either \overline{CS} input are low (or \overline{WR} and either \overline{CS} go low while \overline{LDAC} is low), then the \overline{LDAC} signal must stay low for t_7 or longer after \overline{WR} returns high to ensure correct data is latched through to the output. The write cycle timing diagram for the AD7248 is shown in Figure 7.

An alternate scheme for writing data to the AD7248 is to tie the \overline{CSMSB} and \overline{LDAC} inputs together. In this case exercising \overline{CSLSB} and \overline{WR} latches the lower 8 bits into the input latch. The second write, which exercises \overline{CSMSB} , \overline{WR} and \overline{LDAC} loads the upper 4-bit nibble to the input latch and at the same time transfers the 12-bit data to the DAC latch. This automatic transfer mode updates the output of the AD7248 in two write operations. This scheme works equally well for \overline{CSLSB} and \overline{LDAC} tied together provided the upper 4-bit nibble is loaded to the input latch followed by a write to the lower 8 bits of the input latch.

CSLSB	CSMSB	WR	LDAC	Function
L	Н	L	Н	Loads LS Byte into Input Latch
L	Н	₹	Н	Latches LS Byte into Input Latch
.	Н	L	H	Latches LS Byte into Input Latch
H	L	L	Н	Loads MS Nibble into Input Latch
Н	L	₹	H	Latches MS Nibble into Input Latch
Н	₹	L	Н	Latches MS Nibble into Input Latch
Н	Н	Н	L	Loads Input Latch into DAC Latch
Н	Н	Н	.	Latches Input Latch into DAC Latch
H	L	L	L	Loads MS Nibble into Input Latch and
				Loads Input Latch into DAC Latch
Н	Н	Н	Н	No Data Transfer Operation

 $H = High State \quad L = Low State$

Table II. AD7248 Truth Table

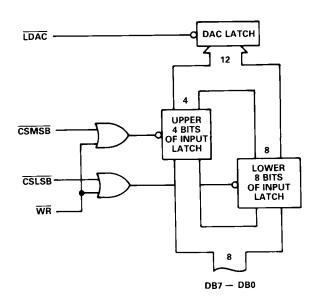


Figure 6. AD7248 Input Control Logic

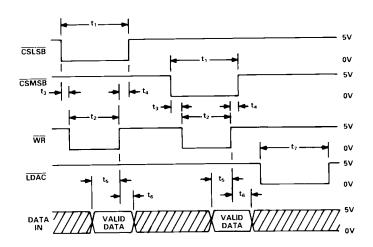


Figure 7. AD7248 Write Cycle Timing Diagram

APPLYING THE AD7245/AD7248

The internal scaling resistors provided on the AD7245/AD7248 allow several output voltage ranges. The part can produce unipolar output ranges of 0V to +5V or 0V to +10V and a bipolar output range of -5V to +5V. Connections for the various ranges are outlined below.

UNIPOLAR (0V to +10V) CONFIGURATION

The first of the configurations provides an output voltage range of 0V to +10V. This is achieved by connecting the bipolar offset resistor, $R_{\rm OFS}$, to AGND and connecting $R_{\rm FB}$ to $V_{\rm OUT}$. In this configuration the AD7245/AD7248 can be operated single supply ($V_{\rm SS}=0V=AGND$). If dual supply performance is required, a $V_{\rm SS}$ of -5V should be applied. Note that a $V_{\rm SS}$ supply more negative than -5V should not be applied to the AD7245/AD7248 when it is configured for a 0 to +10V output range. Figure 8 shows the connection diagram for unipolar operation while the table for output voltage versus the digital code in the DAC latch is shown in Table III.

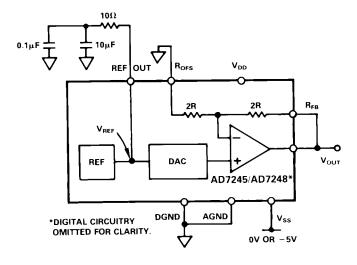


Figure 8. Unipolar (0 to + 10V) Configuration

DAC La	itch Cont	ents LSB	Analog Output, V _{OUT}
1111	1111	1111	$+2 \cdot V_{REF} \cdot \left(\frac{4095}{4096}\right)$
1000	0000	0001	$+2\cdot V_{REF}\cdot \left(\frac{2049}{4096}\right)$
1000	0000	0000	$+2 \cdot V_{REF} \cdot \left(\frac{2048}{4096}\right) = +V_{REF}$
0 1 1 1	1111	1111	$+2 \cdot \mathbf{V_{REF}} \cdot \left(\frac{2047}{4096}\right)$
0000	0000	0001	$+2 \cdot V_{REF} \cdot \left(\frac{1}{4096}\right)$
0000	0000	0000	ov

NOTE:
$$1LSB = 2 \cdot V_{REF}(2^{-12}) = V_{REF} \left(\frac{1}{2048} \right)$$

Table III. Unipolar Code Table (0V to + 10V Range)

UNIPOLAR (0V to +5V) CONFIGURATION

The 0V to +5V output voltage range is achieved by tying R_{OFS} , R_{FB} and V_{OUT} together. For this output range the AD7245/ AD7248 can be operated single supply ($V_{SS}=0V$) or dual supply. The table for output voltage versus digital code is as in Table III, with $2 \cdot V_{REF}$ replaced by V_{REF} . Note that for this range

1LSB =
$$V_{REF}(2^{-12}) = V_{REF} \cdot \frac{1}{4096}$$
.

BIPOLAR CONFIGURATION

The bipolar configuration for the AD7245/AD7248, which gives an output voltage range from $-5\mathrm{V}$ to $+5\mathrm{V}$, is achieved by connecting the R_{OFS} input to REF OUT and connecting R_{FB} and V_{OUT} . The AD7245/AD7248 must be operated from dual supplies to achieve this output voltage range. The code table for bipolar operation is shown in Table IV.

DACL: MSB	atch Cont	ents LSB	Analog Output, V _{OUT}
1111	1111	1111	$+ \mathbf{V}_{REF} \cdot \left(\frac{2047}{2048} \right)$
1000	0000	0 0 0 1	$+V_{REF}\cdot\left(\frac{1}{2048}\right)$
1000	0000	0000	0 v
0 1 1 1	1111	1111	$-V_{REF} \cdot \left(\frac{1}{2048}\right)$
0 0 0 0	0000	0 0 0 1	$-\mathbf{V_{REF}} \cdot \left(\frac{2047}{2048} \right)$
0000	0000	0000	$-V_{REF} \cdot \left(\frac{2048}{2048}\right) = -V_{REF}$

NOTE:
$$1LSB = 2 \cdot V_{REF}(2^{-11}) = V_{REF} \left(\frac{1}{2048}\right)$$

Table IV. Bipolar Code Table

AGND BIAS

The AD7245/AD7248 AGND pin can be biased above system GND (AD7245/AD7248 DGND) to provide an offset "zero" analog output voltage level. With unity gain on the amplifier

 $(R_{OFS} = V_{OUT} = R_{FB})$ the output voltage, V_{OUT} is expressed as:

$$V_{OUT} = V_{BIAS} + D \cdot V_{REF}$$

where D is a fractional representation of the digital word in the DAC latch and V_{BIAS} is the voltage applied to the AD7245/AD7248 AGND pin.

Because the current flowing out of the AGND pin varies with digital code, the AGND pin should be driven from a low impedance source. A circuit configuration is outlined for AGND bias in Figure 9 using the AD589, a +1.23V bandgap reference.

If a gain of 2 is used on the buffer amplifier the output voltage, $V_{\rm OUT}$ is expressed as

$$V_{OUT} = 2(V_{BIAS} + D \cdot V_{REF})$$

In this case care must be taken to ensure that the maximum output voltage is not greater than $V_{\rm DD}-3V$. The $V_{\rm DD}-V_{\rm OUT}$ overhead must be greater than 3V to ensure correct operation of the part. Note that $V_{\rm DD}$ and $V_{\rm SS}$ for the AD7245/AD7248 must be referenced to DGND (system GND). The entire circuit can be operated in single supply with the $V_{\rm SS}$ pin of the AD7245/AD7248 connected to system GND.

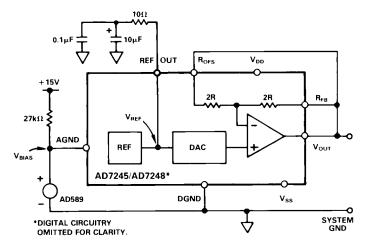


Figure 9. AGND Bias Current

PROGRAMMABLE CURRENT SINK

Figure 10 shows how the AD7245/AD7248 can be configured with a power MOSFET transistor, the VN0300M, to provide a

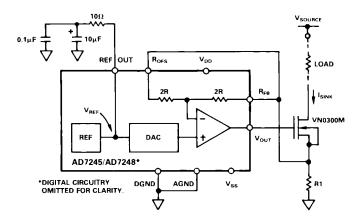


Figure 10. Programmable Current Sink

programmable current sink from $V_{\rm DD}$ or $V_{\rm SOURCE}$. The VN0300M is placed in the feedback of the AD7245/AD7248 amplifier. The entire circuit can be operated in single supply by tying the $V_{\rm SS}$ of the AD7245/AD7248 to AGND. The sink current, $I_{\rm SINK}$, can be expressed as:

$$I_{SINK} = \frac{D \cdot V_{REF}}{R1}$$

Using the VN0300M, the voltage drop across the load can typically be as large as $(V_{SOURCE}-6V)$ with V_{OUT} of the DAC at +5V. Therefore, for a current of 50mA flowing in the R1 (with all 1s in the DAC register) the maximum load is 200 Ω with $V_{SOURCE}=+15V.$ The VN0300M can actually handle currents up to 500mA and still function correctly in the circuit, but in practice the circuit must be used with larger values of V_{SOURCE} otherwise it requires a very small load.

Since the tolerance value on the reference voltage of the AD7245/AD7248 is $\pm 0.2\%$, then the absolute value of I_{SINK} can vary by $\pm 0.2\%$ from device to device for a fixed value of R1.

Because the input bias current of the AD7245/AD7248's op amp is only of the order of pA's, its effect on the sink current is negligible. Tying the $R_{\rm OFS}$ input to the $R_{\rm FB}$ input reduces this effect even further and prevents noise pickup which could occur if the $R_{\rm OFS}$ pin was left unconnected.

The circuit of Figure 10 can be modified to provide a programmable current source to AGND or $-V_{SINK}$ (for $-V_{SINK}$, dual supplies are required on the AD7245/AD7248). The AD7245/AD7248 is configured as before. The current through R1 is mirrored with a current mirror circuit to provide the programmable source current (see CMOS DAC Application Guide, Publication No. G872-30-10/84, for suitable current mirror circuit). As before the absolute value of the source current will be affected by the

 \pm 0.2% tolerance on V_{REF} . In this case the performance of the current mirror will also affect the value of the source current.

FUNCTION GENERATOR WITH PROGRAMMABLE FREQUENCY

Figure 11 shows how the AD7245/AD7248 can be configured with the AD537, voltage-to-frequency converter and the AD639, trigonometric function generator to provide a complete function generator with programmable frequency. The circuit provides square-wave, triwave and sinewave outputs, each output of \pm 10V amplitude.

The AD7245/AD7248 provides a programmable voltage to the AD537 input. Since both the AD7245/AD7248 and AD537 are guaranteed monotonic, the output frequency will always increase with increasing digital code. The AD537 provides a square-wave output which is conditioned for $\pm 10V$ by amplifier A1. The AD537 also provides a differential triwave output. This is conditioned by amplifiers A2 and A3 to provide the $\pm 1.8V$ triwave required at the input of the AD639. The triwave is further scaled by amplifier A4 to provide a $\pm 10V$ output.

Adjusting the triwave applied to the AD639 adjusts the distortion performance of the sine wave output, (+10V in configuration shown). Amplitude, offset and symmetry of the triwave can affect the distortion. By adjusting these, via VR1 and VR2, an output sine wave with harmonic distortion of better than -50dB can be achieved at low and intermediate frequencies.

Using the capacitor value shown in Figure 11 for C_F (i.e. 680pF) the output frequency range is 0 to 100kHz over the digital input code range. The step size for frequency increments is 25Hz. The accuracy of the output frequency is limited to 8 or 9 bits by the AD537, but it is guaranteed monotonic to 12 bits.

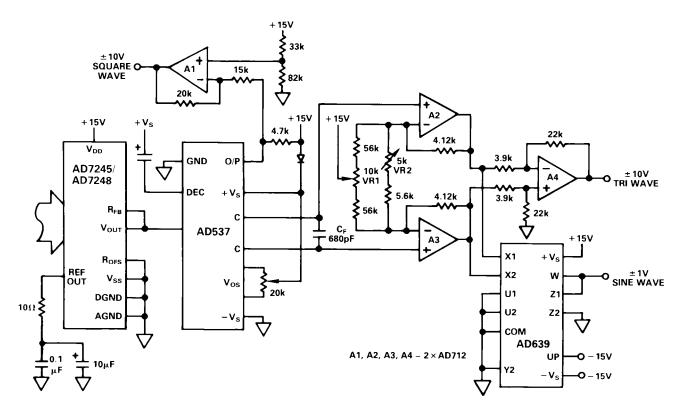


Figure 11. Programmable Function Generator

MICROPROCESSOR INTERFACING – AD7245

AD7245 - 8086A INTERFACE

Figure 12 shows the 8086 16-bit processor interfacing to the AD7245. In the setup shown the double-buffering feature of the DAC is not used and the \overline{LDAC} input is tied LOW. AD0-AD11 of the 16-bit data bus are connected to the AD7245 data bus (DB0-DB11). The 12-bit word is written to the AD7245 in one MOV instruction and the analog output responds immediately. In this example the DAC address is D000. A software routine for Figure 12 is given in Table V.

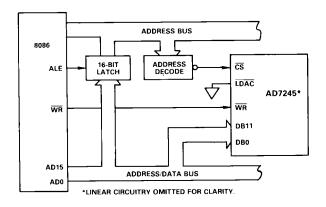


Figure 12. AD7245 to 8086 Interface

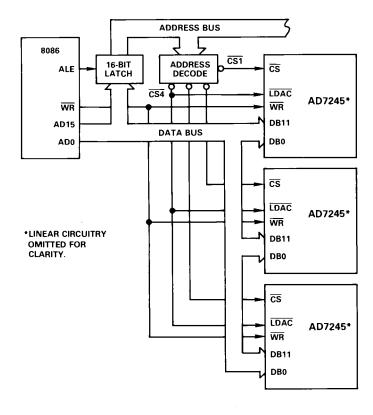


Figure 13. AD7245 to 8086 Multiple DAC Interface

ASSUME DS: DACLOAD, CS: DACLOAD DACLOAD SEGMENT AT 000

00	8CC9	MOVCX,	: DEFINE DATA SEGMENT
		CS	REGISTER
02	8ED9	MOV DS,	: EQUAL TO CODE
		CX	SEGMENT REGISTER
04	BF00D0	MOV DI,	: LOAD DI WITH D000
		#D000	
07	C705	MOV MEM,	: DAC LOADED WITH WXYZ
	"YZWX"	#YZWX	
0B	EA0000		: CONTROL IS RETURNED TO
0E	00 FF		THE MONITOR PROGRAM

Table V. Sample Program for Loading AD7245 from 8086

In a multiple DAC system the double-buffering of the AD7245 allows the user to simultaneously update all DACs. In Figure 13, a 12-bit word is loaded to the input latches of each of the DACs in sequence. Then, with one instruction to the appropriate address, $\overline{CS4}$ (i.e., \overline{LDAC}) is brought LOW, updating all the DACs simultaneously.

AD7245 - MC68000 INTERFACE

Interfacing between the MC68000 and the AD7245 is accomplished using the circuit of Figure 14. Once again the AD7245 is used in the single-buffered mode. A software routine for loading data to the AD7245 is given in Table VI. In this example the AD7245 is located at address E000, and the 12-bit word is written to the DAC in one MOVE instruction.

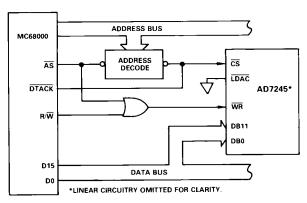


Figure 14. AD7245 to 68000 Interface

01000	MOVE.W	#X,D0	The desired DAC data, X, is loaded into Data Register 0. X may be any value between 0 and 4095 (decimal) or 0 and OFFF (hexadecimal).
	MOVE.W	D0,\$E000	The Data X is transferred between D0 and the
	MOVE.B	#228,D7	DAC Latch. Control is returned to the System Monitor Program using these two
	TRAP	#14	instructions.

Table VI. Sample Routine for Loading AD7245 from 68000

MICROPROCESSOR INTERFACING – AD7248

Figure 15 shows the connection diagram for interfacing the AD7248 to both the 8085A and 8088 microprocessors. This scheme is also suited to the Z80 microprocessor, but the Z80 address/data bus does not have to be demutiplexed. Data to be loaded to the AD7248 is right-justified. The AD7248 is memory mapped with a separate memory address for the input latch high byte, the input latch low byte and the DAC latch. Data is first written to the AD7248 input latch in two write operations. Either the high byte or the low byte data can be written first to the AD7248 input latch. A write to the AD7248 DAC latch address transfers the input latch data to the DAC latch and updates the output voltage. Alternatively, the LDAC input can be asynchronous or can be common to a number of AD7248s for simultaneous updating of a number of voltage channels.

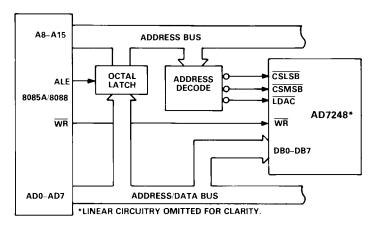


Figure 15. AD7248 to 8085A/8088 Interface

A connection diagram for the interface between the AD7248 and 68008 microprocessor is shown in Figure 16. Once again, the AD7248 acts as a memory mapped device and data is right-justified. In this case the AD7248 is configured in the automatic transfer mode which means that the high byte of the input latch has the same address as the DAC latch. Data is written to the AD7248 by first writing data to the AD7248 low byte. Writing data to the high byte of the input latch also transfers the input latch contents to the DAC latch and updates the output.

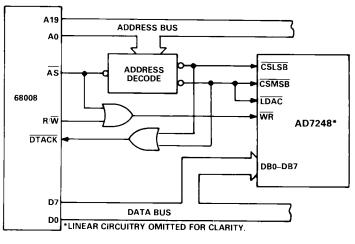


Figure 16. AD7248 to 68008 Interface

An interface circuit for connections to the 6502 or 6809 microprocessors is shown in Figure 17. Once again, the AD7248 is memory mapped and data is right-justified. The procedure for writing data to the AD7248 is as outlined for the 8085A/8088. For the 6502 microprocessor the ϕ 2 clock is used to generate the \overline{WR} , while for the 6809 the E signal is used.

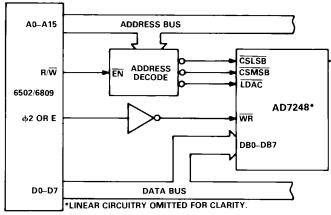


Figure 17. AD7248 to 6502/6809 Interface

Figure 18 shows a connection diagram between the AD7248 and the 8051 microprocessor. The AD7248 is port mapped in this interface and is configured in the automatic transfer mode. Data to be loaded to the input latch low byte is output to Port 1. Output Line P3.0, which is connected to CSLSB of the AD7248, is pulsed to load data into the low byte of the input latch. Pulsing the P3.1 line, after the high byte data has been set up on Port 1, updates the output of the AD7248. The WR input of the AD7248 can be hardwired low in this application because spurious address strobes on CSLSB and CSMSB do not occur.

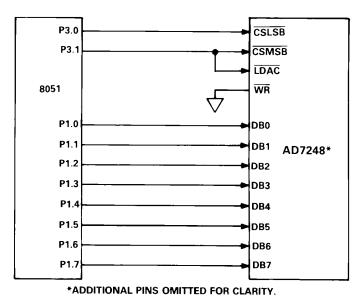


Figure 18. AD7248 to MCS-51 Interface

AD7245 ORDERING INFORMATION

Relative	Temperature Range and Package			
Accuracy (LSB)	0 to + 70°C	-25°C to +85°C	-55℃ to +125℃	
	Plastic DIP	Hermetic DIP ¹	Hermetic DIP ^{1,2}	
± 1	AD7245JN	AD7245AQ	AD7245\$Q	
	PLCC ³		LCCC ⁴	
± 1	AD7245JP		AD7245SE	

NOTES

AD7245 PRICING (100s)

AD7245JN	\$ 9.85	AD7245SQ	\$38.55
AD7245JP	\$11.35	AD7245SE	\$67.50
AD7245AQ	\$12.85		

AD7248 ORDERING INFORMATION

Relative	Temperature Range and Package			
Accuracy (LSB)	0 to +70°C	-25°C to +85°C	-55°C to +125°C	
	Plastic DIP	Hermetic DIP ¹	Hermetic DIP ^{1,2}	
± l	AD7248JN	AD7248AQ	AD7248SQ	
	PLCC ³		LCCC4	
± 1	AD7248JP		AD7248SE	

NOTES

Analog Devices reserves the right to ship either ceramic (D-20) or cerdip (Q-20) hermetic

packages.

To order MIL-STD-883, Class B processed parts, add/883B to part number. Contact your

local sales office for military data sheet.

3PLCC: Plastic Leaded Chip Carrier.

4LCCC: Leadless Ceramic Chip Carrier.

AD7248 PRICING (100s)

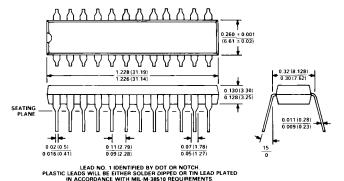
AD7248JN	\$ 9.85	AD7248SQ	\$38.55
AD7248JP	\$11.35	AD7248SE	\$67.50
AD7248AO	\$12.85		

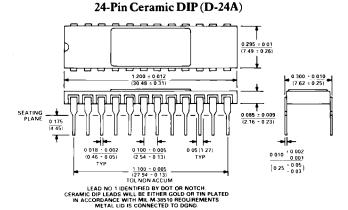
MECHANICAL INFORMATION – AD7245

OUTLINE DIMENSION

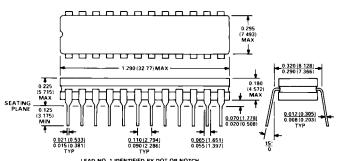
Dimensions shown in inches and (mm).

24-Pin Plastic DIP (N-24)



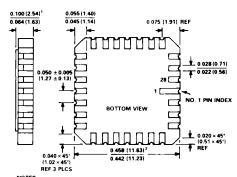


24-Pin Cerdip (Q-24)



LEAD NO. 1 IDENTIFIED BY DOT OR NOTCH.
CERDIP LEADS WILL BE EITHER TIN PLATED OR SOLDER DIPPED
IN ACCORDANCE WITH MIL-M-38510 REQUIREMENTS.

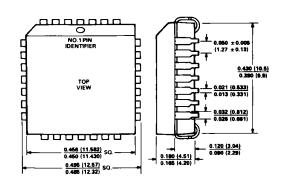
28-Terminal **Leadless Ceramic Chip** Carrier (E-28A)



NOTES

TO SIMENSION CONTROLS THE OVERALL PACKAGE THICKNESS:
"APPLIES TO ALL FOUR SIDES.
ALL TERMINALS ARE GOLD PLATED.

28-Terminal Plastic Leaded Chip Carrier (P-28A)



Analog Devices reserves the right to ship either ceramic (D-24A) or cerdip (Q-24) hermetic

packages.
*To order MIL-STD-883, Class B processed parts, add /883B to part number. Contact your local sales office for military data sheet.

*PLCC: Plastic Leaded Chip Carrier.

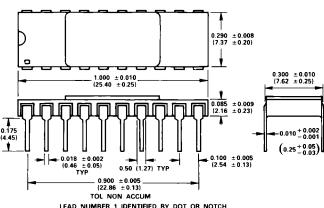
LCCC: Leadless Ceramic Chip Carrier.

MECHANICAL INFORMATION – AD7248

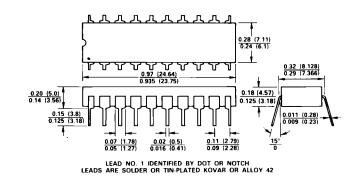
OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

20-Pin Ceramic DIP (D-20)

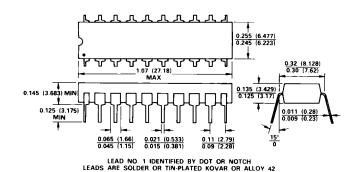


20-Pin Cerdip (Q-20)

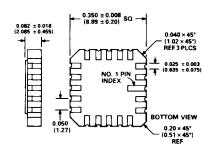


LEAD NUMBER 1 IDENTIFIED BY DOT OR NOTCH.
LEADS WILL BE EITHER GOLD OR TIN PLATED IN ACCORDANCE
WITH MIL-M-38510 REQUIREMENTS.

20-Pin Plastic DIP (N-20)



20-Terminal Leadless Ceramic Chip Carrier (E-20A)



20-Terminal Plastic Leaded Chip Carrier (P-20A)

